

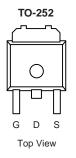
SPD04N80C3-VB Datasheet

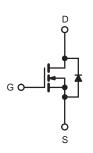
N-Channel 800V (D-S)Super Junction Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	800				
R _{DS(on)} (Ω)	$V_{GS} = 10 V$	1.2			
Q _g (Max.) (nC)	200				
Q _{gs} (nC)	24				
Q _{gd} (nC)	110				
Configuration	Single				

FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC





N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _C	= 25 °C, unless otherw	ise noted)			
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage	V _{DS}	800	V		
Gate-Source Voltage	V _{GS}	± 20	v		
Continuous Drain Current	V_{GS} at 10 V $T_C = 25 \degree C$	1-	5		
	V_{GS} at 10 V $T_C = 100 ^{\circ}C$	ID -	3.9	A	
Pulsed Drain Current ^a	I _{DM}	21	1		
Linear Derating Factor		1.5	W/°C		
Single Pulse Avalanche Energy ^b	E _{AS}	770	mJ		
Repetitive Avalanche Current ^a	I _{AR}	7.8	A		
Repetitive Avalanche Energy ^a		E _{AR}	19	mJ	
Maximum Power Dissipation	T _C = 25 °C	PD	190	W	
Peak Diode Recovery dV/dt ^c	dV/dt	2.0	V/ns		
Operating Junction and Storage Temperature Rang	T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for 10 s		300 ^d		
Mounting Torque	6-32 or M3 screw		10	lbf ∙ in	
	0-32 OF IVIS SCREW		1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 23 mH, $R_g = 25 \Omega$, $I_{AS} = 7.8 \text{ A}$ (see fig. 12). c. $I_{SD} \leq 7.8 \text{ A}$, dl/dt $\leq 140 \text{ A/}\mu\text{s}$, $V_{DD} \leq 600 \text{ V}$, $T_J \leq 150 \text{ °C}$.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

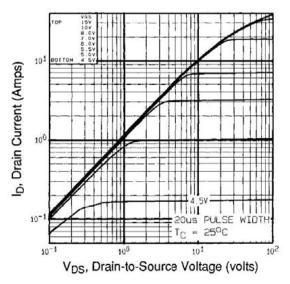


THERMAL RESISTANCE RATII	NGS							
PARAMETER	SYMBOL	TYP.		MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	- 40 0.24 -						
Case-to-Sink, Flat, Greased Surface	R _{thCS}				°C/W			
Maximum Junction-to-Case (Drain)	R _{thJC}	- 0.65						
SPECIFICATIONS (T _J = 25 °C, u	nless otherwi	se noted)			1	1	•	1
PARAMETER	SYMBOL	TES	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT
Static		1				1	1	1
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D =	250 µA	800	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	$I_D = 1 \text{ mA}$	-	0.98	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V_{GS} , I_D =	250 µA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 20 V$			-	± 100	nA
Zoro Gato Voltago Drain Current	I	V _{DS} =	= 800 V, V _C	_{as} = 0 V	-	-	100	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 640 \	$V_{\rm GS} = 0$	∕, T _J = 125 °C	-	-	500	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	١c	_b = 3.7 A ^b	-	1.2	-	Ω
Forward Transconductance	g _{fs}	V _{DS} =	100 V, I _D	= 3.7 A ^b	5.6	-	-	S
Dynamic								•
Input Capacitance	C _{iss}		V _{GS} = 0 \	1	-	3100	-	pF
Output Capacitance	C _{oss}	1	$V_{DS} = 25$	V,	-	800	-	
Reverse Transfer Capacitance	C _{rss}	f = 1	f = 1.0 MHz, see fig. 5		-	490	-	
Total Gate Charge	Qg			-	-	200		
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		A, $V_{DS} = 400 V$, iq. 6 and 13 ^b	-	-	24	nC
Gate-Drain Charge	Q _{gd}		300 1	ig. 0 and 10	-	-	110	
Turn-On Delay Time	t _{d(on)}				-	19	-	<u> </u>
Rise Time	tr	V _{DD} = 400 V, I _D = 3.8 A,			-	38	-	ns
Turn-Off Delay Time	t _{d(off)}	R _g =	R_{g} = 6.2 Ω, R_{D} = 52 Ω		-	120	-	
Fall Time	t _f	see fig. 10 ^b		-	39	-	1	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from		-	5.0	-	nH	
Internal Source Inductance	L _S	die contact			-	13		-
Drain-Source Body Diode Characteristic	S							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	5.0	A	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	21		
Body Diode Voltage	V _{SD}	$T_{J} = 25 \text{ °C}, I_{S} = 3.8 \text{ A}, V_{GS} = 0 \text{ V}^{b}$		-	-	1.8	V	
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 3.8 A, dl/dt = 100 A/μs ^b		: 3.8 A.	-	650	980	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	3.8	5.7	μC	
Forward Turn-On Time	t _{on}	Intrinsic tu	rn-on time	is negligible (turn	-on is dor	ninated h	by Ls and	Ln)

Notes

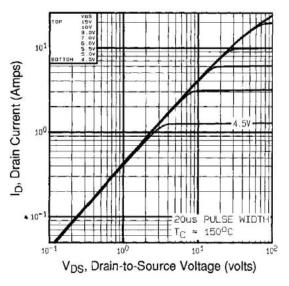
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)







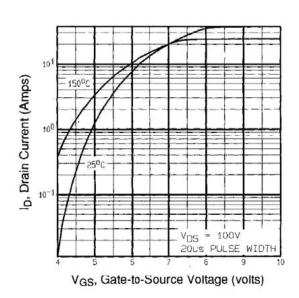
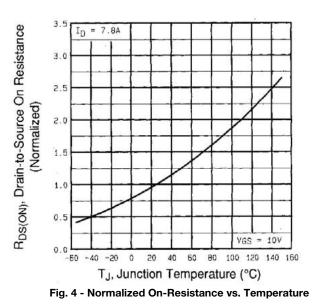


Fig. 3 - Typical Transfer Characteristics





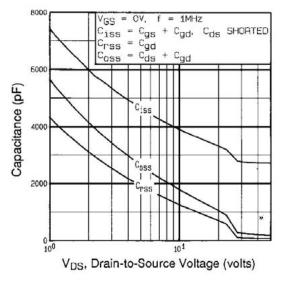
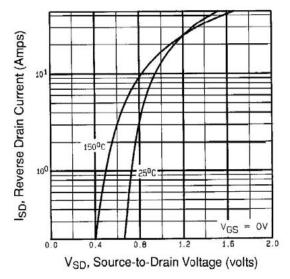


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage





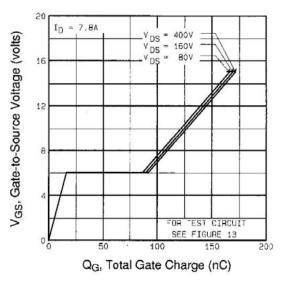
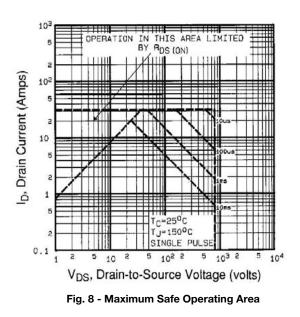


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



SPD04N80C3-VB



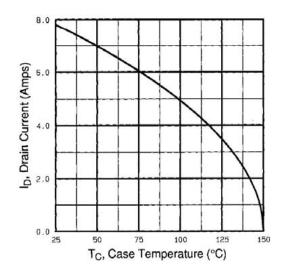


Fig. 9 - Maximum Drain Current vs. Case Temperature

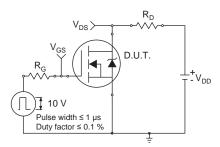


Fig. 10a - Switching Time Test Circuit

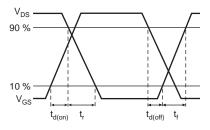


Fig. 10b - Switching Time Waveforms

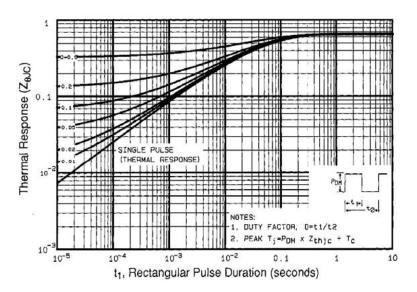


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



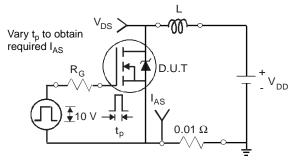


Fig. 12a - Unclamped Inductive Test Circuit

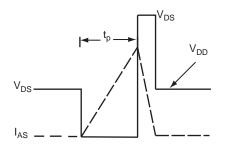


Fig. 12b - Unclamped Inductive Waveforms

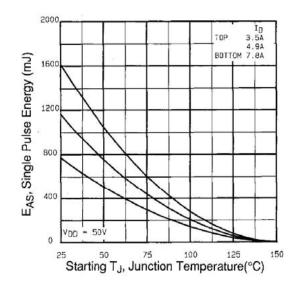


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

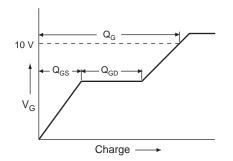


Fig. 13a - Basic Gate Charge Waveform

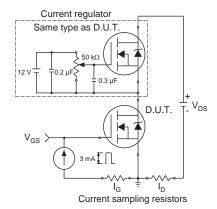
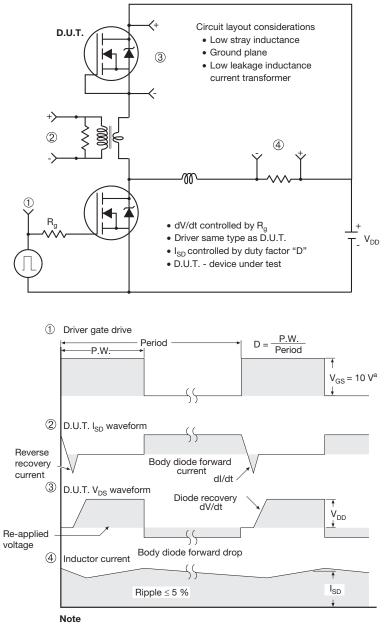


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



a. $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel



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